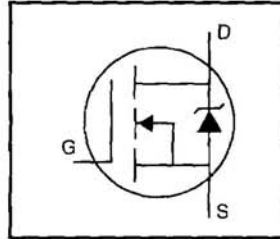


# IRFI744GPbF

## HEXFET® Power MOSFET

- Isolated Package
- High Voltage Isolation= 2.5KVRMS ⑤
- Sink to Lead Creepage Dist.= 4.8mm
- Dynamic dv/dt Rating
- Low Thermal Resistance
- Lead-Free



$$V_{DSS} = 450V$$

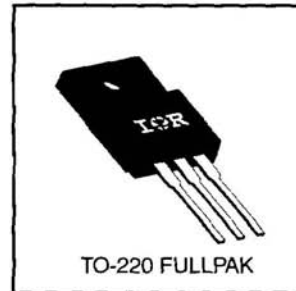
$$R_{DS(on)} = 0.63\Omega$$

$$I_D = 4.9A$$

### Description

Third Generation HEXFETs from International Rectifier provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220 Fullpak eliminates the need for additional insulating hardware in commercial-industrial applications. The moulding compound used provides a high isolation capability and a low thermal resistance between the tab and external heatsink. This isolation is equivalent to using a 100 micron mica barrier with standard TO-220 product. The Fullpak is mounted to a heatsink using a single clip or by a single screw fixing.



### Absolute Maximum Ratings

	Parameter	Max.	Units
$I_D @ T_C = 25^\circ C$	Continuous Drain Current, $V_{GS} @ 10 V$	4.9	A
$I_D @ T_C = 100^\circ C$	Continuous Drain Current, $V_{GS} @ 10 V$	3.1	
$I_{DM}$	Pulsed Drain Current ①	20	
$P_D @ T_C = 25^\circ C$	Power Dissipation	40	W
	Linear Derating Factor	0.32	W/°C
$V_{GS}$	Gate-to-Source Voltage	$\pm 20$	V
$E_{AS}$	Single Pulse Avalanche Energy ②	130	mJ
$I_{AR}$	Avalanche Current ①	4.9	A
$E_{AR}$	Repetitive Avalanche Energy ①	4.0	mJ
dv/dt	Peak Diode Recovery dv/dt ③	3.5	V/ns
$T_J$	Operating Junction and	-55 to +150	°C
$T_{STG}$	Storage Temperature Range		
	Soldering Temperature, for 10 seconds	300 (1.6mm from case)	
	Mounting Torque, 6-32 or M3 screw	10 lbf•in (1.1 N•m)	

### Thermal Resistance

	Parameter	Min.	Typ.	Max.	Units
$R_{\theta JC}$	Junction-to-Case	—	—	3.1	°C/W
$R_{\theta JA}$	Junction-to-Ambient	—	—	65	

## Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

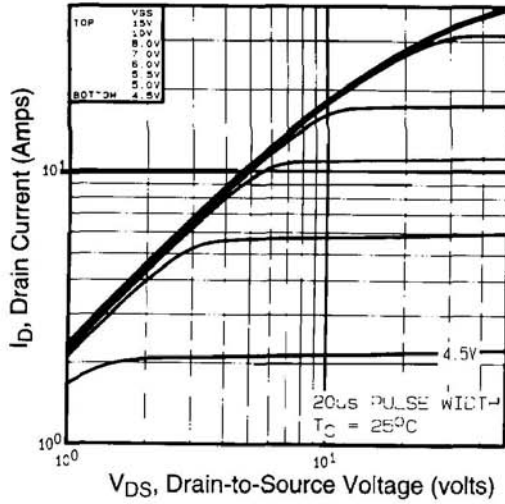
Parameter	Min.	Typ.	Max.	Units	Test Conditions
V <sub>(BR)DSS</sub>	450	—	—	V	V <sub>GS</sub> =0V, I <sub>D</sub> =250μA
ΔV <sub>(BR)DSS</sub> /ΔT <sub>J</sub>	—	0.59	—	V/°C	Reference to 25°C, I <sub>D</sub> =1mA
R <sub>DS(on)</sub>	—	—	0.63	Ω	V <sub>GS</sub> =10V, I <sub>D</sub> =2.9A ④
V <sub>GS(th)</sub>	2.0	—	4.0	V	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA
g <sub>fS</sub>	3.3	—	—	S	V <sub>DS</sub> =50V, I <sub>D</sub> =2.9A ④
I <sub>DSS</sub>	—	—	25	μA	V <sub>DS</sub> =450V, V <sub>GS</sub> =0V
I <sub>DSS</sub>	—	—	250	μA	V <sub>DS</sub> =360V, V <sub>GS</sub> =0V, T <sub>J</sub> =125°C
I <sub>GSS</sub>	—	—	100	nA	V <sub>GS</sub> =20V
I <sub>GSS</sub>	—	—	-100	nA	V <sub>GS</sub> =-20V
Q <sub>g</sub>	—	—	80	nC	I <sub>D</sub> =8.8A
Q <sub>gs</sub>	—	—	12	nC	V <sub>DS</sub> =360V
Q <sub>gd</sub>	—	—	41	nC	V <sub>GS</sub> =10V See Fig. 6 and 13 ④
t <sub>d(on)</sub>	—	8.7	—	ns	V <sub>DD</sub> =225V
t <sub>r</sub>	—	28	—	ns	I <sub>D</sub> =8.8A
t <sub>d(off)</sub>	—	58	—	ns	R <sub>G</sub> =9.1Ω
t <sub>f</sub>	—	27	—	ns	R <sub>D</sub> =25Ω See Figure 10 ④
L <sub>D</sub>	—	4.5	—	nH	Between lead, 6 mm (0.25in.) from package and center of die contact
L <sub>S</sub>	—	7.5	—	nH	
C <sub>iss</sub>	—	1400	—	pF	V <sub>GS</sub> =0V
C <sub>oss</sub>	—	370	—	pF	V <sub>DS</sub> =25V
C <sub>rss</sub>	—	140	—	pF	f=1.0MHz See Figure 5
C	—	12	—	pF	f=1.0MHz

## Source-Drain Ratings and Characteristics

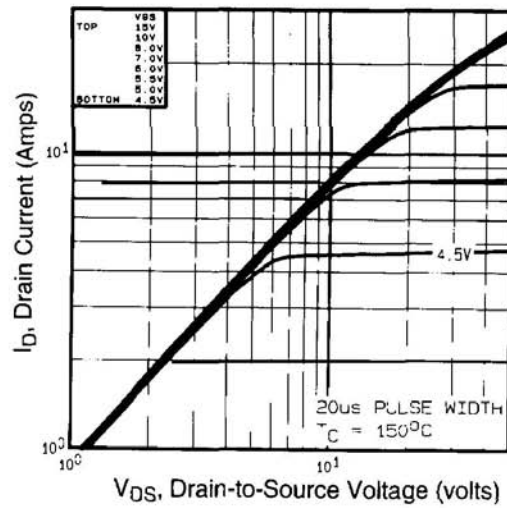
Parameter	Min.	Typ.	Max.	Units	Test Conditions
I <sub>S</sub>	—	—	4.9	A	MOSFET symbol showing the integral reverse p-n junction diode.
I <sub>SM</sub>	—	—	20	A	
V <sub>SD</sub>	—	—	2.0	V	T <sub>J</sub> =25°C, I <sub>S</sub> =8.8A, V <sub>GS</sub> =0V ④
t <sub>rr</sub>	—	490	740	ns	T <sub>J</sub> =25°C, I <sub>F</sub> =8.8A
Q <sub>rr</sub>	—	3.2	4.8	μC	di/dt=100A/μs ④
t <sub>on</sub>	Intrinsic turn-on time is negligible (turn-on is dominated by L <sub>S</sub> +L <sub>D</sub> )				

### Notes:

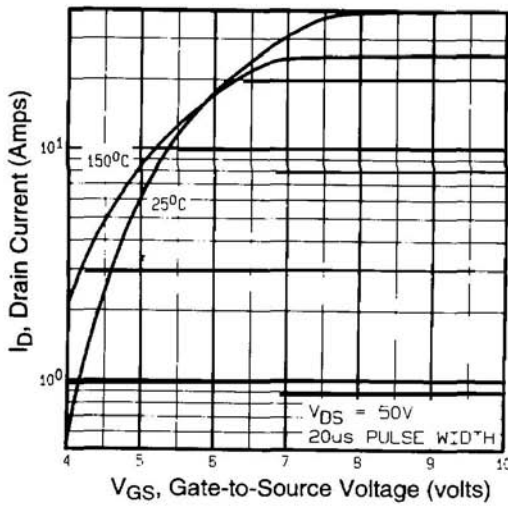
- ① Repetitive rating; pulse width limited by max. junction temperature (See Figure 11)
- ② V<sub>DD</sub>=50V, starting T<sub>J</sub>=25°C, L=9.6mH R<sub>G</sub>=25Ω, I<sub>AS</sub>=4.9A (See Figure 12)
- ③ I<sub>SD</sub>≤8.8A, di/dt≤200A/μs, V<sub>DD</sub>≤V<sub>(BR)DSS</sub>, T<sub>J</sub>≤150°C
- ④ Pulse width ≤ 300 μs; duty cycle ≤2%.
- ⑤ t=60s, f=60Hz



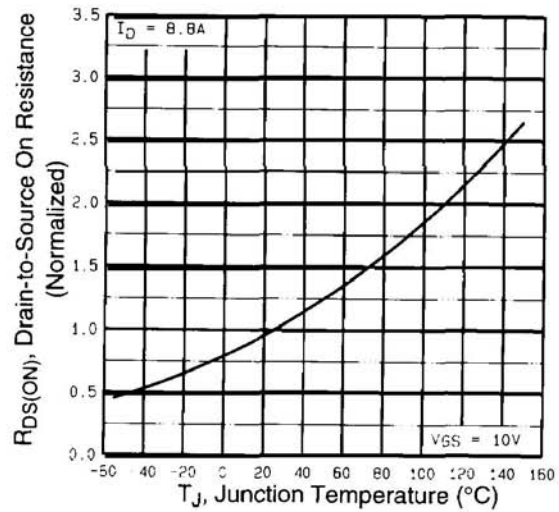
**Fig 1.** Typical Output Characteristics,  
 $T_C=25^\circ\text{C}$



**Fig 2.** Typical Output Characteristics,  
 $T_C=150^\circ\text{C}$



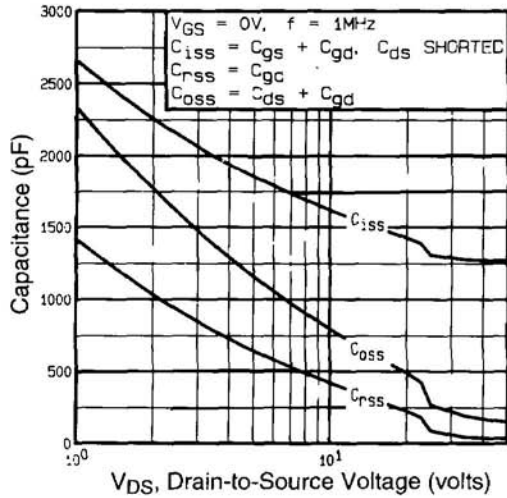
**Fig 3.** Typical Transfer Characteristics



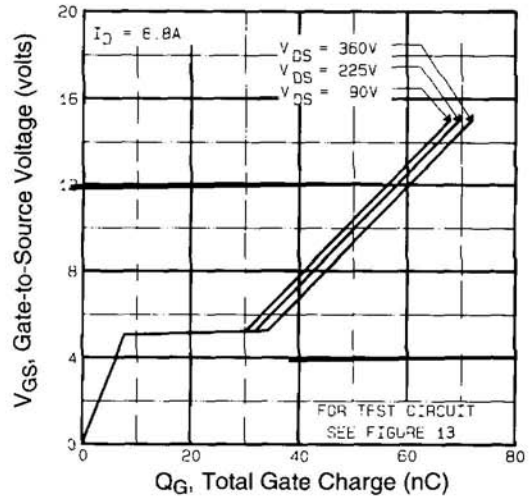
**Fig 4.** Normalized On-Resistance  
Vs. Temperature

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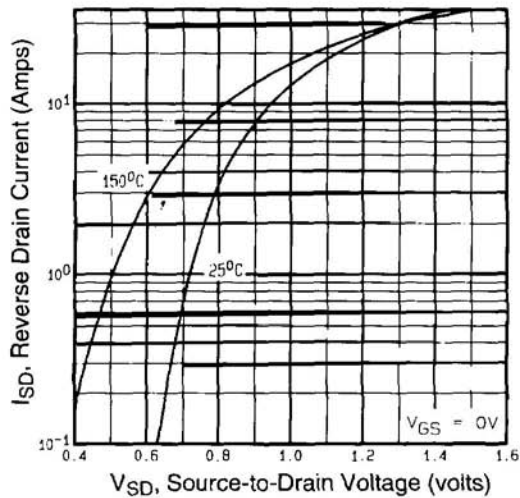
International  
**IR** Rectifier



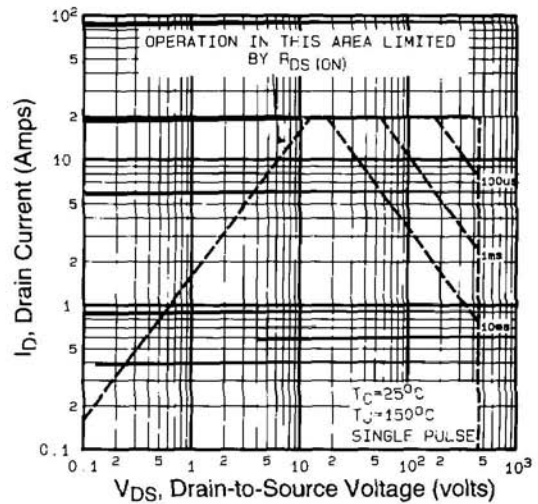
**Fig 5.** Typical Capacitance Vs. Drain-to-Source Voltage



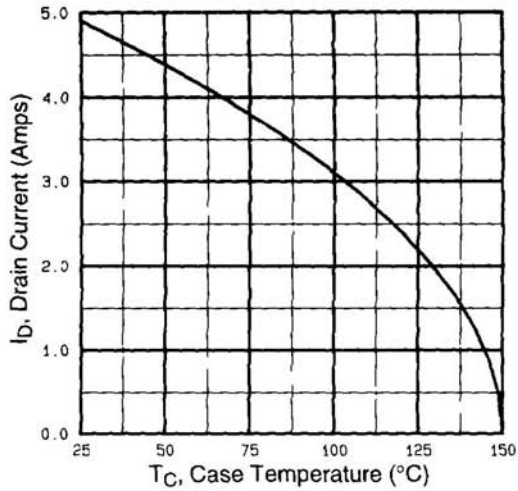
**Fig 6.** Typical Gate Charge Vs. Gate-to-Source Voltage



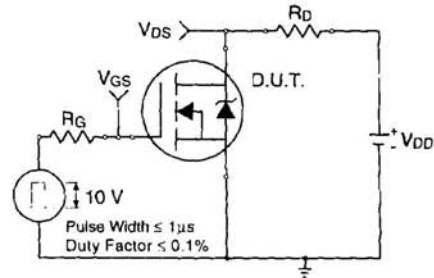
**Fig 7.** Typical Source-Drain Diode Forward Voltage



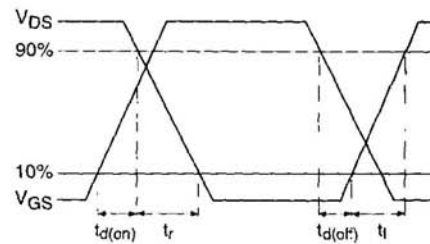
**Fig 8.** Maximum Safe Operating Area



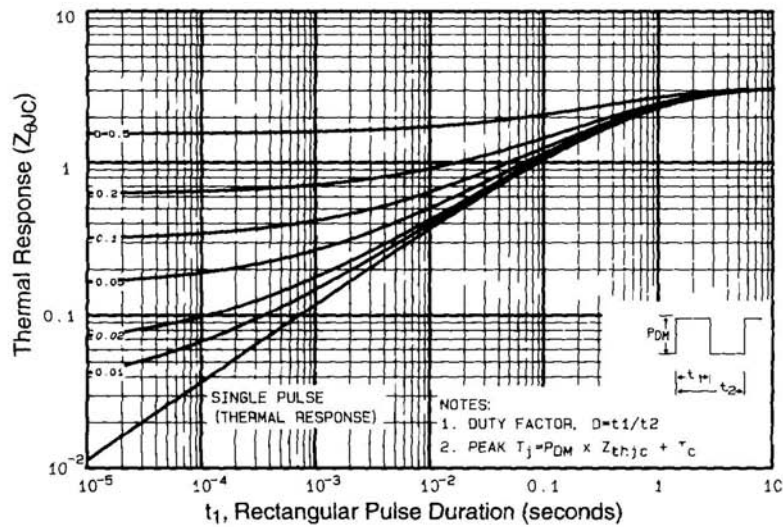
**Fig 9.** Maximum Drain Current Vs. Case Temperature



**Fig 10a.** Switching Time Test Circuit



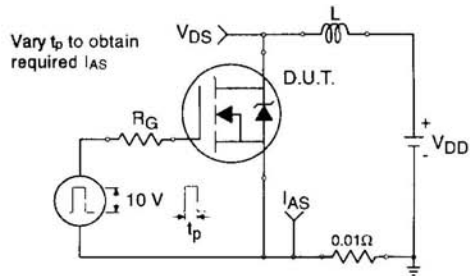
**Fig 10b.** Switching Time Waveforms



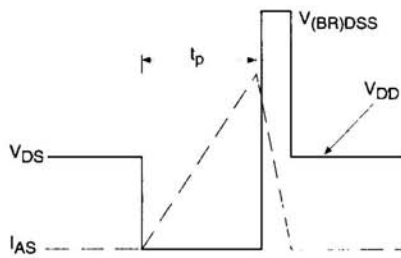
**Fig 11.** Maximum Effective Transient Thermal Impedance, Junction-to-Case

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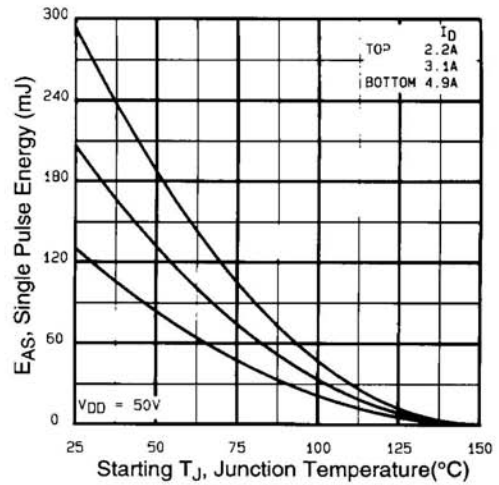
International  
**IR** Rectifier



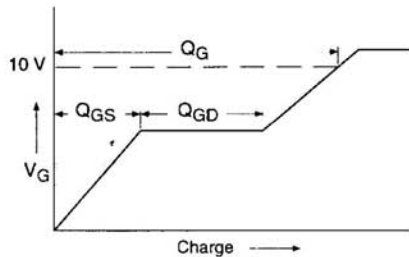
**Fig 12a.** Unclamped Inductive Test Circuit



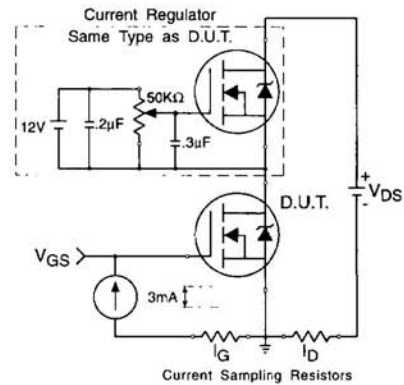
**Fig 12b.** Unclamped Inductive Waveforms



**Fig 12c.** Maximum Avalanche Energy Vs. Drain Current



**Fig 13a.** Basic Gate Charge Waveform



**Fig 13b.** Gate Charge Test Circuit

**Appendix A:** Figure 14, Peak Diode Recovery  $dv/dt$  Test Circuit

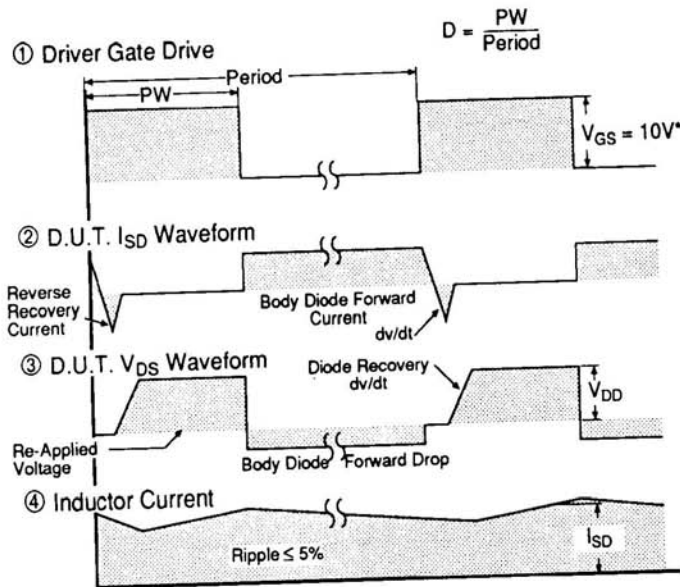
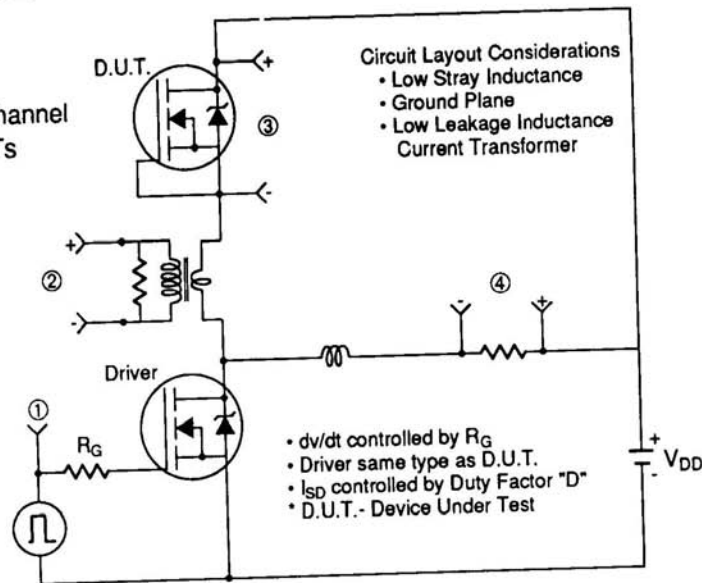
**Appendix B:** Package Outline Mechanical Drawing

**Appendix C:** Part Marking Information

**Appendix A**

**Peak Diode Recovery dv/dt Test Circuit**

**Fig 14.** For N-Channel HEXFETs



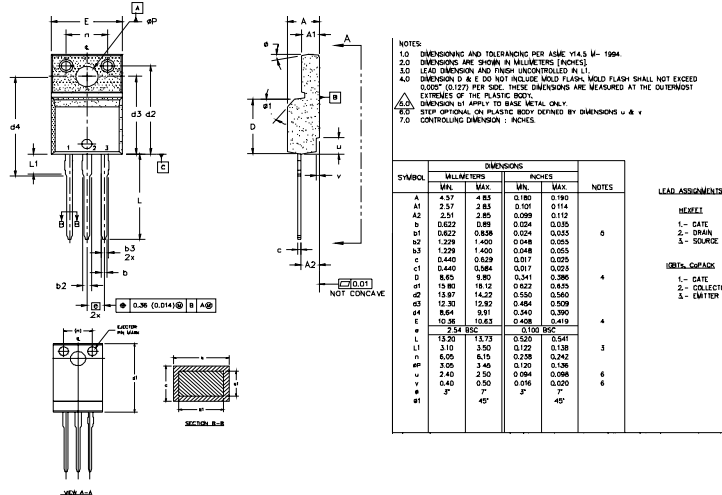
\*  $V_{GS} = 5V$  for Logic Level Devices

# IRFI744GPbF

International  
**IR** Rectifier

## TO-220 Full-Pak Package Outline

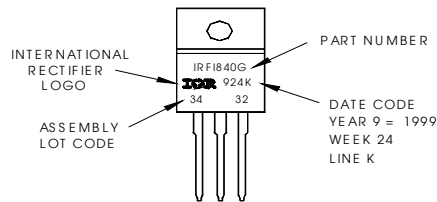
Dimensions are shown in millimeters (inches)



## TO-220 Full-Pak Part Marking Information

EXAMPLE: THIS IS AN IRFI840G  
 WITH ASSEMBLY  
 LOT CODE 3432  
 ASSEMBLED ON WW 24 1999  
 IN THE ASSEMBLY LINE "K"

**Note:** "P" in assembly line position indicates "Lead-Free"



Data and specifications subject to change without notice.

International  
**IR** Rectifier

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TAC Fax: (310) 252-7903

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Note: For the most current drawings please refer to the IR website at:  
<http://www.irf.com/package/>